

#### Final datasheet

#### EasyPACK™ module with CoolSiC™ Trench MOSFET and PressFIT / NTC

#### **Features**

- · Electrical features
  - V<sub>DSS</sub> = 2000 V
  - $I_{DN} = 160 \text{ A} / I_{DRM} = 320 \text{ A}$
  - Overload operation up to 175°C
  - Suitable Infineon gate drivers can be found under https://www.infineon.com/gdfinder
- Mechanical features
  - Integrated NTC temperature sensor
  - PressFIT contact technology

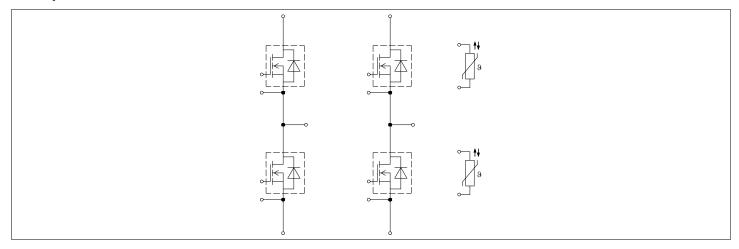
#### **Potential applications**

- EV charging
- Energy storage systems (ESS)
- Solar applications
- DC/DC converter

#### **Product validation**

• Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

#### **Description**





# **EasyPACK™ module**





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### **EasyPACK™ module**

1 Package



# 1 Package

#### Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V <sub>ISOL</sub>	RMS, f = 50 Hz, t = 1 min	3.2	kV
Isolation test voltage NTC	V <sub>ISOL(NTC)</sub>	RMS, f = 50 Hz, t = 1 min	3.2	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al <sub>2</sub> O <sub>3</sub>	
Comparative tracking index	СТІ		> 400	
Relative thermal index (electrical)	RTI	housing	140	°C

#### Table 2 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Stray inductance module	L <sub>sCE</sub>				22		nH
Module lead resistance, terminals - chip	R <sub>CC'+EE'</sub>	T <sub>H</sub> = 25 °C, per switch			1.4		mΩ
Storage temperature	$T_{\rm stg}$			-40		125	°C
Mounting torque for module mounting	М	- Mounting according to valid application note	M5, Screw	1.3		1.5	Nm
Weight	G		-		78		g

**Note**: The current under continuous operation is limited to 25A rms per connector pin.

# 2 MOSFET, T1-T4

#### Table 3 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Drain-source voltage	$V_{\rm DSS}$		T <sub>vj</sub> = 25 °C	2000	V
Implemented drain current	I <sub>DN</sub>			160	А
Continuous DC drain current	I <sub>DDC</sub>	$T_{\rm vj}$ = 175 °C, $V_{\rm GS}$ = 18 V	T <sub>H</sub> = 65 °C	135	A
Repetitive peak drain current	/ <sub>DRM</sub>	verified by design, t <sub>p</sub> limited by T <sub>vjmax</sub>		320	A
Gate-source voltage, max. transient voltage	$V_{GS}$	D < 0.01		-10/23	V
Gate-source voltage, max. static voltage	$V_{GS}$			-7/20	V

# **EasyPACK™ module**

2 MOSFET, T1-T4



#### Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	V <sub>GS(on)</sub>		1518	V
Off-state gate voltage	V <sub>GS(off)</sub>		-52	V

#### Table 5 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min. Typ.		Max.	
Drain-source on-resistance	R <sub>DS(on)</sub>	I <sub>D</sub> = 160 A	V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 25 °C		5.1	8.1	mΩ
			V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 125 °C		10.9		
			V <sub>GS</sub> = 18 V, T <sub>vj</sub> = 175 °C		15.4		
			$V_{\rm GS} = 15 \text{ V},$ $T_{\rm vj} = 25 ^{\circ}\text{C}$		5.6		
Gate threshold voltage	V <sub>GS(th)</sub>	$I_D = 112 \text{ mA}, V_{DS} = V_{GS}, \text{ (te pulse at V}_{GS} = +20 \text{ V)}, T_{vj} =$		3.45	4.3	5.15	V
Total gate charge	Q <sub>G</sub>	$V_{\rm DD}$ = 1200 V, $V_{\rm GS}$ = -3 V, T <sub>v</sub>	<sub>/j</sub> = 25 °C		0.78		μC
Internal gate resistor	R <sub>Gint</sub>	T <sub>vj</sub> = 25 °C			1.8		Ω
Input capacitance	C <sub>ISS</sub>	$f = 100 \text{ kHz}, V_{DS} = 1200 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		24.1		nF
Output capacitance	C <sub>OSS</sub>	$f = 100 \text{ kHz}, V_{DS} = 1200 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.563		nF
Reverse transfer capacitance	C <sub>rss</sub>	$f = 100 \text{ kHz}, V_{DS} = 1200 \text{ V},$ $V_{GS} = 0 \text{ V}$	T <sub>vj</sub> = 25 °C		0.041		nF
C <sub>OSS</sub> stored energy	E <sub>OSS</sub>	$V_{\rm DS}$ = 1200 V, $V_{\rm GS}$ = -3/18 V	/, T <sub>vj</sub> = 25 °C		508		μJ
Drain-source leakage current	I <sub>DSS</sub>	$V_{\rm DS}$ = 2000 V, $V_{\rm GS}$ = -3 V	T <sub>vj</sub> = 25 °C		0.04	378	μA
Gate-source leakage current	I <sub>GSS</sub>	$V_{\rm DS} = 0 \text{ V}, T_{\rm vj} = 25 ^{\circ}\text{C}$	V <sub>GS</sub> = 20 V			400	nA
Turn-on delay time	t <sub>d on</sub>	$I_{\rm D} = 160  \text{A}, R_{\rm Gon} = 4.3  \Omega,$	T <sub>vj</sub> = 25 °C		70		ns
(inductive load)	e load)	$V_{DD} = 1200 \text{ V},$ $V_{GS} = -3/18 \text{ V},$	T <sub>vj</sub> = 125 °C		69		
		$t_{\text{dead}} = 1000 \text{ ns}, 0.1 \text{ V}_{\text{GS}}$ to 0.1 I <sub>D</sub>	T <sub>vj</sub> = 175 °C		69		
Rise time (inductive load)	t <sub>r</sub>	$I_{\rm D} = 160  \text{A}, R_{\rm Gon} = 4.3  \Omega,$	T <sub>vj</sub> = 25 °C		29		ns
		$V_{\rm DD} = 1200  \text{V},$	T <sub>vj</sub> = 125 °C		29		
		$V_{GS} = -3/18 \text{ V},$ $t_{dead} = 1000 \text{ ns}, 0.1 \text{ I}_{D} \text{ to}$ $0.9 \text{ I}_{D}$	T <sub>vj</sub> = 175 °C		29		

(table continues...)

#### **EasyPACK™** module

3 Body diode (MOSFET, T1-T4)



#### Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Turn-off delay time	t <sub>d off</sub>	$I_{\rm D} = 160  \text{A}, R_{\rm Goff} = 0.51  \Omega,$	T <sub>vj</sub> = 25 °C		107		ns
(inductive load)		$V_{DD} = 1200 \text{ V},$ $V_{GS} = -3/18 \text{ V}, 0.9 \text{ V}_{GS} \text{ to}$	T <sub>vj</sub> = 125 °C		113		
		0.9 I <sub>D</sub>	T <sub>vj</sub> = 175 °C		119		
Fall time (inductive load)	t <sub>f</sub>	$I_{\rm D} = 160 \text{ A}, R_{\rm Goff} = 0.51 \Omega,$	T <sub>vj</sub> = 25 °C		33		ns
		$V_{DD} = 1200 \text{ V},$ $V_{GS} = -3/18 \text{ V}, 0.9 \text{ I}_{D} \text{ to } 0.1$	T <sub>vj</sub> = 125 °C		36		
		I <sub>D</sub>	T <sub>vj</sub> = 175 °C		38		
Turn-on energy loss per	E <sub>on</sub>		T <sub>vj</sub> = 25 °C		10.8		mJ
pulse	$R_{Gon} = 4.3 \Omega$ , $\alpha I/\alpha t = -$	T <sub>vj</sub> = 125 °C		12.5			
		T <sub>vj</sub> = 175 °C		15.1			
Turn-on energy loss per	E <sub>on,o</sub>	$I_{\rm D} = 160 \text{ A}, V_{\rm DD} = 1200 \text{ V},$ $L_{\sigma} = 15 \text{ nH}, V_{\rm GS} = -3/18 \text{ V},$ $R_{\rm Gon,o} = 2.4 \Omega, \text{ di/dt} =$	T <sub>vj</sub> = 25 °C		7.6		mJ
pulse, optimized			T <sub>vj</sub> = 125 °C		7.9		
		$6 \text{ kA/µs } (T_{\text{vj}} = 175 \text{ °C}),$ $t_{\text{dead}} = 100 \text{ ns}$	T <sub>vj</sub> = 175 °C		8.7		
Turn-off energy loss per	E <sub>off</sub>	$I_{\rm D}$ = 160 A, $V_{\rm DD}$ = 1200 V,	T <sub>vj</sub> = 25 °C		2.7		mJ
pulse		$L_{\sigma} = 15 \text{ nH}, V_{GS} = -3/18 \text{ V},$ $R_{Goff} = 0.51 \Omega, \text{ dv/dt} =$	T <sub>vj</sub> = 125 °C		3		1
		T <sub>vj</sub> = 175 °C		3.1			
Thermal resistance, junction to heat sink	R <sub>thJH</sub>	per MOSFET, $\lambda_{\text{grease}} = 3.3$	W/(m·K)		0.238		K/W
Temperature under switching conditions	T <sub>vj op</sub>			-40		175	°C

#### Note:

The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

 $T_{\rm vj\,op}$  > 150 °C is allowed for operation at overload conditions. For detailed specifications, please refer to AN 2018-14.

# 3 Body diode (MOSFET, T1-T4)

#### Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I <sub>SD</sub>	$T_{\rm vj} = 175 {\rm ^{\circ}C},  V_{\rm GS} = -3 {\rm V}$	T <sub>H</sub> = 65 °C	100	A

# EasyPACK™ module

4 NTC-Thermistor



#### Table 7 Characteristic values

Parameter	Symbol	Note or test condition			Values		Unit
				Min.	Тур.	Max.	
Forward voltage	V <sub>SD</sub>	$I_{SD} = 160 \text{ A}, V_{GS} = -3 \text{ V}$	T <sub>vj</sub> = 25 °C		4.4	5.95	V
			T <sub>vj</sub> = 125 °C		4		
			T <sub>vj</sub> = 175 °C		3.85		
Peak reverse recovery	I <sub>rrm</sub>	$I_{SD} = 160 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		88		А
current		4 F L(A / )/ - 1200 \/	T <sub>vj</sub> = 125 °C		118		
			T <sub>vj</sub> = 175 °C		162		
Recovered charge	Q <sub>rr</sub>	$I_{SD}$ = 160 A, di <sub>s</sub> /dt = 4.5 kA/µs, $V_{DD}$ = 1200 V, $V_{GS}$ = -3 V, $t_{dead}$ = 1000 ns	T <sub>vj</sub> = 25 °C		4.3		μC
			T <sub>vj</sub> = 125 °C		5.9		
			T <sub>vj</sub> = 175 °C		8.8		
Reverse recovery energy	E <sub>rec</sub>	$I_{SD} = 160 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		3.5		mJ
		$4.5 \text{ kA/}\mu\text{s} (T_{\text{vj}} = 175 \text{ °C}),$ $V_{\text{DD}} = 1200 \text{ V}, V_{\text{GS}} = -3 \text{ V},$	T <sub>vj</sub> = 125 °C		4.3		
		$t_{\text{dead}} = 1000 \text{ ns}$	T <sub>vj</sub> = 175 °C		5.4		
Reverse recovery energy, optimized	E <sub>rec,o</sub>	$I_{SD} = 160 \text{ A, di}_{s}/\text{dt} =$	T <sub>vj</sub> = 25 °C		2.5		mJ
		6 kA/μs (T <sub>vj</sub> = 175 °C),	T <sub>vj</sub> = 125 °C		2.8		
		$V_{\rm DD} = 1200 \text{ V}, V_{\rm GS} = -3 \text{ V},$ $t_{\rm dead} = 100 \text{ ns}$	T <sub>vj</sub> = 175 °C		4.1		

# 4 NTC-Thermistor

#### Table 8 Characteristic values

Parameter	Symbol	Symbol Note or test condition		Values		
			Min.	Тур.	Max.	
Rated resistance	R <sub>25</sub>	T <sub>NTC</sub> = 25 °C		5		kΩ
Deviation of R <sub>100</sub>	∆R/R	$T_{\rm NTC} = 100 {}^{\circ}{\rm C}$ , $R_{100} = 493 \Omega$	-5		5	%
Power dissipation	P <sub>25</sub>	T <sub>NTC</sub> = 25 °C			20	mW
B-value	B <sub>25/50</sub>	$R_2 = R_{25} \exp[B_{25/50}(1/T_2-1/(298,15 \text{ K}))]$		3375		К
B-value	B <sub>25/80</sub>	$R_2 = R_{25} \exp[B_{25/80}(1/T_2-1/(298,15 \text{ K}))]$		3411		K
B-value	B <sub>25/100</sub>	$R_2 = R_{25} \exp[B_{25/100}(1/T_2-1/(298,15 \text{ K}))]$		3433		K

**Note**: For an analytical description of the NTC characteristics please refer to AN2009-10, chapter 4

#### EasyPACK™ module

5 Characteristics diagrams

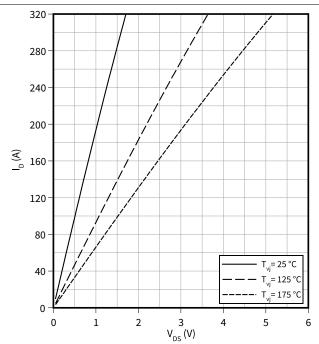


# **5** Characteristics diagrams

#### Output characteristic (typical), MOSFET, T1-T4

 $I_D = f(V_{DS})$ 

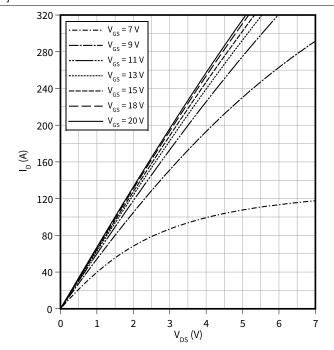
 $V_{GS} = 18 V$ 



#### Output characteristic field (typical), MOSFET, T1-T4

 $I_D = f(V_{DS})$ 

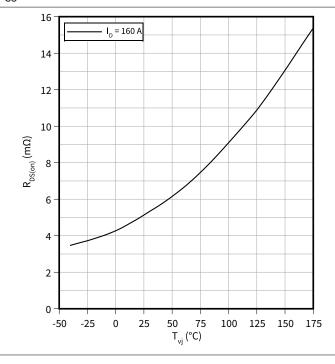
T<sub>vj</sub> = 175 °C



#### Drain source on-resistance (typical), MOSFET, T1-T4

 $R_{DS(on)} = f(T_{vj})$ 

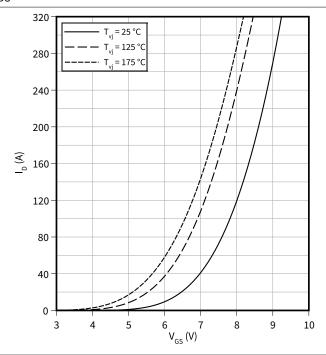
 $V_{GS} = 18 V$ 



#### Transfer characteristic (typical), MOSFET, T1-T4

 $I_D = f(V_{GS})$ 

 $V_{DS} = 20 V$ 



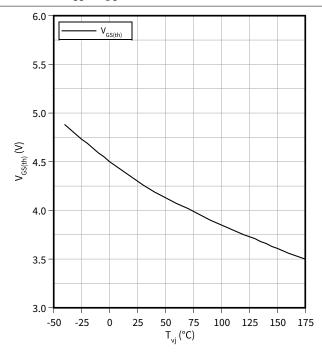
#### EasyPACK™ module

5 Characteristics diagrams



# Gate-source threshold voltage (typical), MOSFET, T1-T4

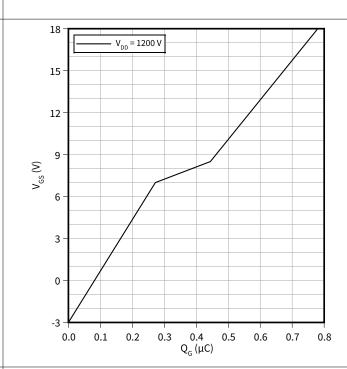
 $V_{GS(th)} = f(T_{vj})$  $I_D = 112 \text{ mA}, V_{GS} = V_{DS}$ 



### Gate charge characteristic (typical), MOSFET, T1-T4

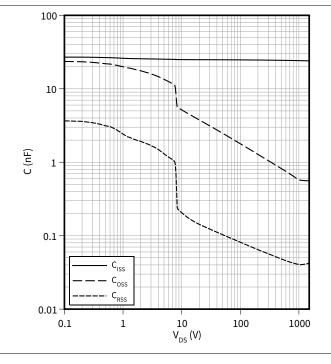
 $V_{GS} = f(Q_G)$ 

 $I_D = 160 A$ ,  $T_{vi} = 25 °C$ 



### Capacity characteristic (typical), MOSFET, T1-T4

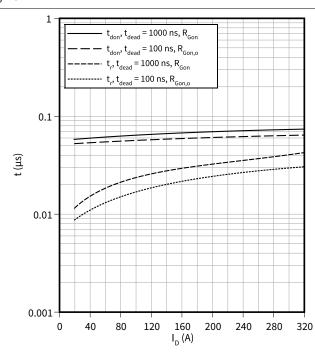
 $C = f(V_{DS})$ f = 100 kHz,  $T_{vi}$  = 25 °C,  $V_{GS}$  = 0 V



### Switching times (typical), MOSFET, T1-T4

 $t = f(I_D)$ 

 $V_{DD}$  = 1200 V,  $R_{Gon}$  = 4.3  $\Omega,\,R_{Gon,o}$  = 2.4  $\Omega,\,T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



#### EasyPACK™ module

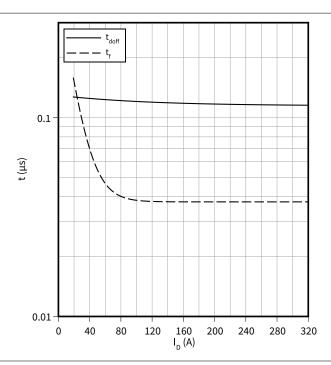
5 Characteristics diagrams



### Switching times (typical), MOSFET, T1-T4

 $t = f(I_D)$ 

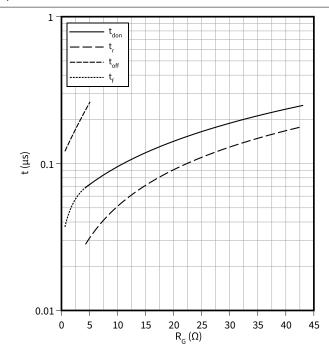
 $R_{Goff} = 0.51 \Omega$ ,  $V_{DD} = 1200 V$ ,  $T_{vi} = 175 °C$ ,  $V_{GS} = -3/18 V$ 



#### Switching times (typical), MOSFET, T1-T4

 $t = f(R_G)$ 

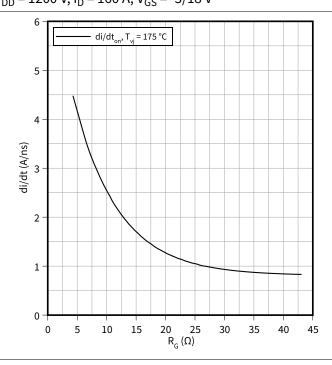
 $V_{DD}$  = 1200 V,  $t_{dead}$  = 1000 ns,  $I_{D}$  = 160 A,  $T_{vj}$  = 175 °C,  $V_{GS}$  = -3/18 V



#### Current slope (typical), MOSFET, T1-T4

 $di/dt = f(R_G)$ 

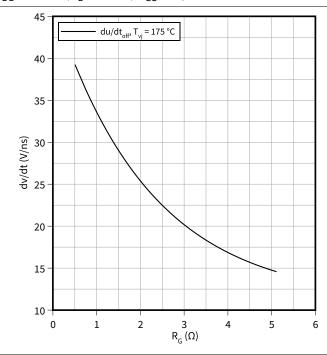
 $V_{DD}$  = 1200 V,  $I_{D}$  = 160 A,  $V_{GS}$  = -3/18 V



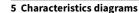
#### Voltage slope (typical), MOSFET, T1-T4

 $dv/dt = f(R_G)$ 

 $V_{DD} = 1200 \text{ V}, I_D = 160 \text{ A}, V_{GS} = -3/18 \text{ V}$ 



#### EasyPACK™ module

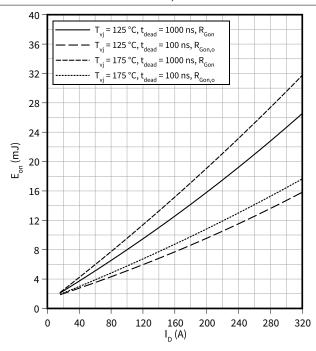




#### Switching losses (typical), MOSFET, T1-T4

$$E_{on} = f(I_D)$$

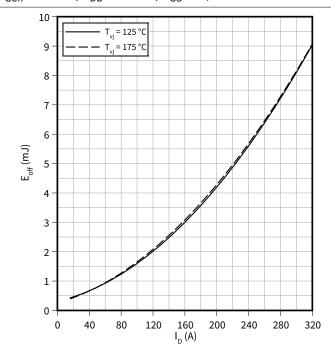
$$V_{DD} = 1200 \text{ V}, R_{Gon} = 4.3 \Omega, R_{Gon,o} = 2.4 \Omega, V_{GS} = -3/18 \text{ V}$$



#### Switching losses (typical), MOSFET, T1-T4

 $E_{off} = f(I_D)$ 

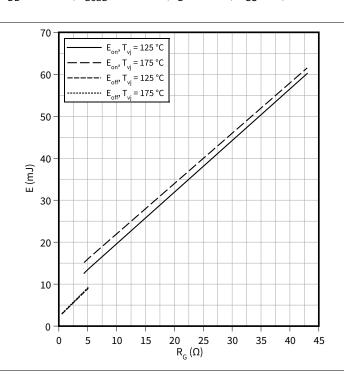
 $R_{Goff} = 0.51 \Omega$ ,  $V_{DD} = 1200 V$ ,  $V_{GS} = -3/18 V$ 



#### Switching losses (typical), MOSFET, T1-T4

 $E = f(R_G)$ 

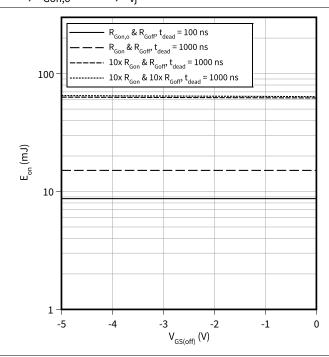
 $V_{DD} = 1200 \text{ V}, t_{dead} = 1000 \text{ ns}, I_D = 160 \text{ A}, V_{GS} = -3/18 \text{ V}$ 



#### Switching losses (typical), MOSFET, T1-T4

 $\mathsf{E}_{\mathsf{on}} = \mathsf{f}(\mathsf{V}_{\mathsf{GS}(\mathsf{off})})$ 

 $R_{Goff}$  = 0.51  $\Omega,$   $V_{DD}$  = 1200 V,  $R_{Gon}$  = 4.3  $\Omega,$   $V_{GS(on)}$  = 18 V,  $I_{D}$  = 160 A,  $R_{Gon,o}$  = 2.4  $\Omega,$   $T_{vj}$  = 175 °C



### **EasyPACK™ module**

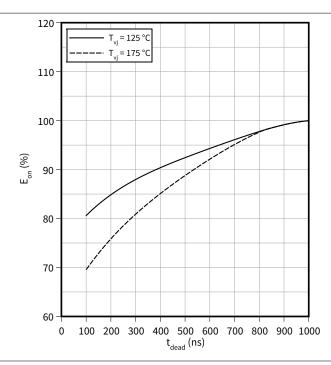




### Switching losses (typical), MOSFET, T1-T4

$$E_{on} = f(t_{dead})$$

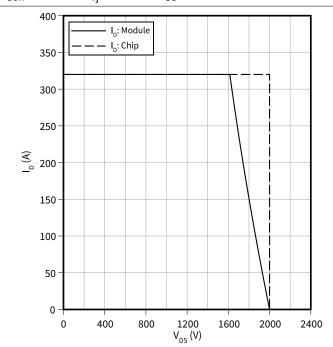
$$R_{Gon} = 4.3 \Omega$$
,  $I_{D} = 160 A$ ,  $V_{DD} = 1200 V$ ,  $V_{GS} = -3/18 V$ 



# Reverse bias safe operating area (RBSOA), MOSFET, T1-T4

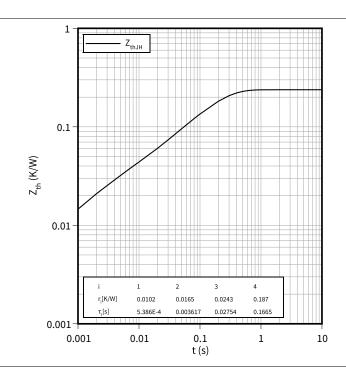
$$I_D = f(V_{DS})$$

$$R_{Goff} = 0.51 \Omega$$
,  $T_{vi} = 175 °C$ ,  $V_{GS} = -3/18 V$ 



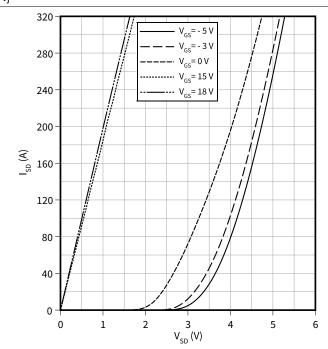
# Transient thermal impedance, MOSFET, T1-T4

#### $Z_{th} = f(t)$



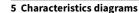
# Forward characteristic body diode (typical), MOSFET, T1-T4

$$I_{SD} = f(V_{SD})$$



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#### EasyPACK™ module

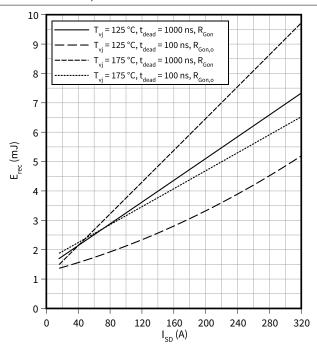




### Switching losses body diode (typical), MOSFET, T1-T4

 $E_{rec} = f(I_{SD})$ 

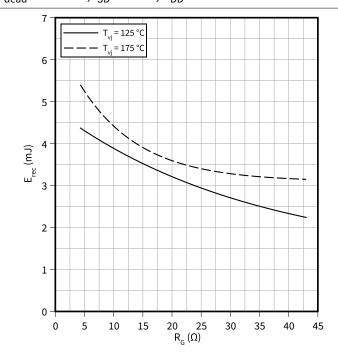
$$R_{Gon} = 4.3 \Omega$$
,  $R_{Gon,o} = 2.4 \Omega$ ,  $V_{DD} = 1200 V$ 



### Switching losses body diode (typical), MOSFET, T1-T4

 $E_{rec} = f(R_G)$ 

$$t_{dead}$$
 = 1000 ns,  $I_{SD}$  = 160 A,  $V_{DD}$  = 1200 V

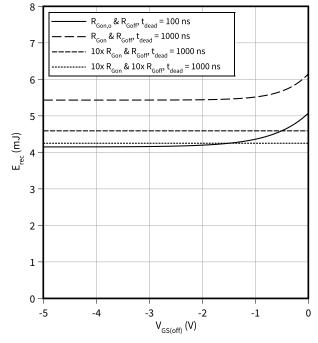


# Switching losses body diode (typical), MOSFET, T1-T4

 $E_{rec} = f(V_{GS(off)})$ 

$$R_{Goff} = 0.51 \Omega$$
,  $R_{Gon} = 4.3 \Omega$ ,  $V_{GS(on)} = 18 V$ ,  $I_{SD} = 160 A$ ,

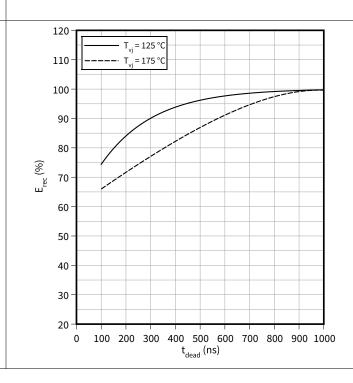
 $R_{Gon,o} = 2.4 \Omega, V_{DD} = 1200 V, T_{vj} = 175 °C$ 



#### Switching losses body diode (typical), MOSFET, T1-T4

 $E_{rec} = f(t_{dead})$ 

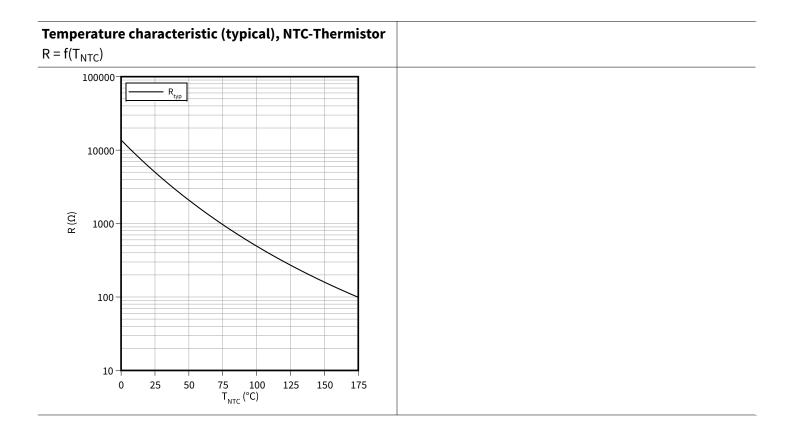
$$R_{Gon} = 4.3 \Omega$$
,  $I_D = 160 A$ ,  $V_{DD} = 1200 V$ ,  $V_{GS} = -3/18 V$ 



# EasyPACK™ module



5 Characteristics diagrams



6 Circuit diagram



# 6 Circuit diagram

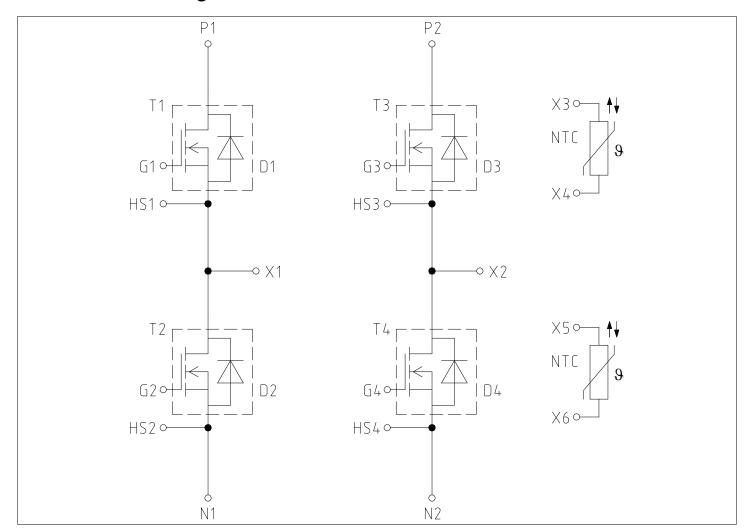


Figure 1

7 Package outlines



# 7 Package outlines

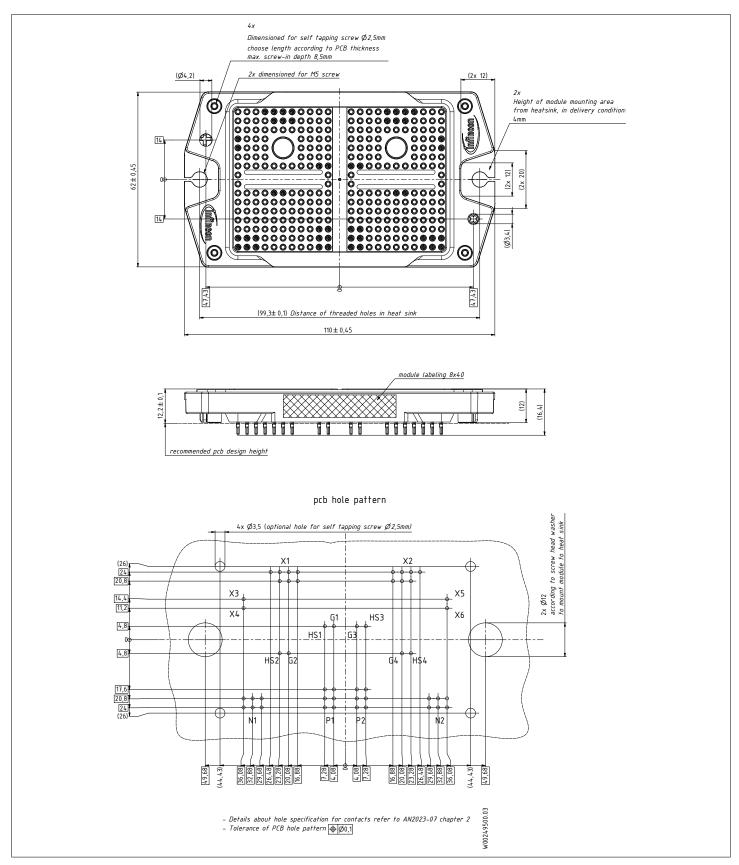


Figure 2

# **EasyPACK™ module**

8 Module label code



# 8 Module label code

Code format	Data Matrix		Barcode C	Code128
Encoding	ASCII text		Code Set	Ą
Symbol size	16x16		23 digits	
Standard	IEC24720 and IEC16022		IEC8859-1	
Code content	Content Digit  Module serial number 1 - 5  Module material number 6 - 11  Production order number 12 - 19  Date code (production year) 20 - 21  Date code (production week) 22 - 23			Example 71549 142846 55054991 15 30
Example	71549142846550549911530			6550549911530

Figure 3

# **EasyPACK™ module**

Revision history



# **Revision history**

Document revision	Date of release	Description of changes
0.10	2024-08-12	Initial version
1.00	2024-11-11	Final datasheet

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